

19-3986; Rev 0; 10/91

MAXIM

Complete, 12-Bit Multiplying DAC

General Description

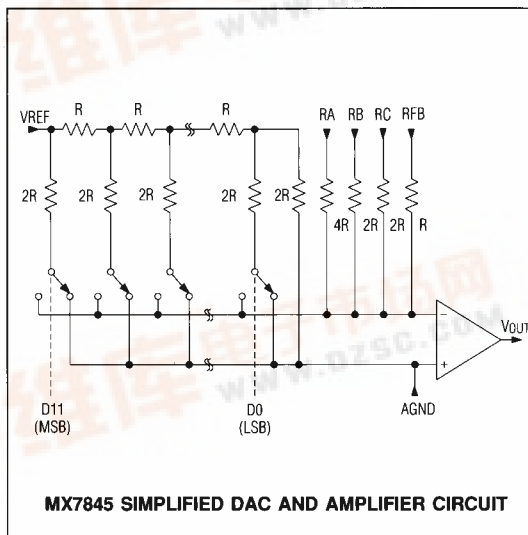
The MX7845 is a 12-bit, voltage-output, 4-quadrant, multiplying digital-to-analog converter (DAC). A precision internal output amplifier and thin-film resistors, laser-trimmed at the wafer level, maintain accuracy over the full operating temperature range. The output amplifier is internally compensated and drives $\pm 10V$ into a $2k\Omega$ load.

The MX7845 has buffered latches that are easily interfaced with microprocessors. Data is transferred into the input register from a 12-bit-wide data path. The input registers are controlled by standard CHIP SELECT (CS) and WRITE (WR) signals. For stand-alone operation, the CS and WR inputs are grounded, making all latches transparent. All logic inputs are level-triggered and compatible with TTL and +5V CMOS logic levels. For a detailed description of MX7845 operation, refer to the MAX501/MAX502 data sheet.

Applications

Automatic Test Equipment
Digital Attenuators
Programmable Power Supplies
Programmable-Gain Amplifiers
Digital to 4-20mA Converters

Functional Diagram



Features

- ◆ Complete MDAC with Output Amplifier
- ◆ 4-Quadrant Multiplication
- ◆ Guaranteed Monotonic (T_{MIN} to T_{MAX})
- ◆ Matched Application Resistors
- ◆ Small 0.3" 24-Pin DIP Package

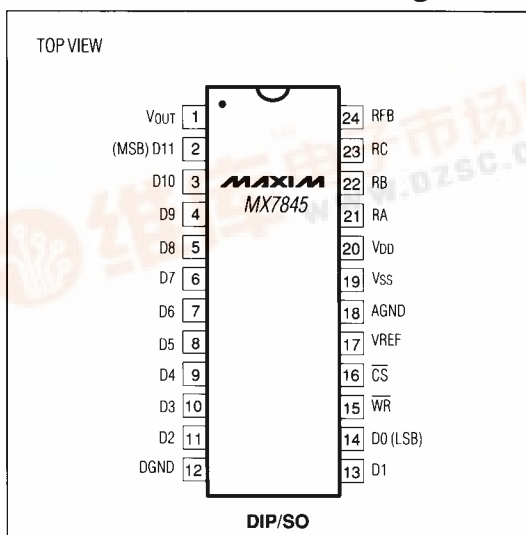
Ordering Information

PART	TEMP. RANGE	PIN-PACKAGE
MX7845JN	0°C to +70°C	24 Narrow Plastic DIP
MX7845KN	0°C to +70°C	24 Narrow Plastic DIP
MX7845JR	0°C to +70°C	24 Wide SO
MX7845KR	0°C to +70°C	24 Wide SO
MX7845JP	0°C to +70°C	28 PLCC
MX7845KP	0°C to +70°C	28 PLCC
MX7845J/D	0°C to +70°C	Dice*
MX7845AEWG	-40°C to +85°C	24 Wide SO
MX7845BEWG	-40°C to +85°C	24 Wide SO
MX7845AQ	-40°C to +85°C	24 Narrow CERDIP
MX7845BQ	-40°C to +85°C	24 Narrow CERDIP
MX7845SE	-55°C to +125°C	28 LCC**
MX7845SQ	-55°C to +125°C	24 Narrow CERDIP**
MX7845TQ	-55°C to +125°C	24 Narrow CERDIP**

* Contact factory for dice specifications.

** Contact factory for availability and processing to MIL-STD-883.

Pin Configuration



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ABSOLUTE MAXIMUM RATINGS

V _{DD} to DGND	-0.3V, +17V
V _{SS} to DGND	+0.3V, -17V
V _{REF} to AGND	±25V
V _{RFB} to AGND	±25V
V _{RA} to AGND	±25V
V _{RB} to AGND	±25V
V _{RC} to AGND	±25V
V _{OUT} to AGND (Note 1)	V _{DD} + 0.3V, V _{SS} - 0.3V
V _{DD} to AGND	-0.3V, +17V
AGND to DGND	-0.3V, V _{DD}

Digital Input Voltage to DGND	-0.3V, V _{DD} + 0.3V
Continuous Power Dissipation (any package)	to +75°C 650mW
derate above +75°C	10mW/°C
Operating Temperature Ranges:	
MX7845J/K	0°C to +70°C
MX7845A/B	-40°C to +85°C
MX7845S/T	-55°C to +125°C
Storage Temperature Range	-65°C to +150°C
Lead Temperature (soldering, 10 sec)	+300°C

Note 1: V_{OUT} may be shorted to AGND, V_{DD}, or V_{SS} if the package power dissipation is not exceeded.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ELECTRICAL CHARACTERISTICS

(V_{DD} = +15V ±5%, V_{SS} = -15V ±5%, V_{REF} = +10V, AGND = DGND = 0V, V_{OUT} connected to R_FB, R_L = 2kΩ, C_L = 100pF, T_A = T_{MIN} to T_{MAX}, all grades, unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
ACCURACY						
Resolution	N		12			Bits
Relative Accuracy (Note 2)	INT	T _A = +25°C	MX7845K/B/T		±1/2	LSB
			MX7845J/A/S		±1	
			MX7845K		±3/4	
			MX7845J/B/T		±1	
			MX7845A		±3/2	
			MX7845S		±2	
Differential Nonlinearity	DNL				±1	LSB
Zero-Code Offset Error (Note 3)		T _A = +25°C	MX7845K/B/T		±1	mV
			MX7845J/A/S		±2	
			MX7845K/B		±3	
			MX7845J/A/T		±4	
			MX7845S		±5	
Offset Temperature Coefficient	ΔVOS/ ΔTemp			±5		μV/°C
Gain Error		R _F B, V _{OUT} connected	MX7845K/B/T		±3	LSB
			MX7845J/A/S		±6	
		R _C or R _B , V _{OUT} connected; V _{REF} = 5V	MX7845K/B/T		±6	
			MX7845J/A/S		±9	
		R _A , V _{OUT} connected; V _{REF} = 2.5V	MX7845K/B/T		±8	
			MX7845J/A/S		±10	
Gain Temperature Coefficient	ΔGain/ ΔTemp	R _F B, V _{OUT} connected		±2		ppm of FSR/°C
Reference Input Resistance			8	12	16	kΩ
Application Resistor Ratio Matching		R _A to R _B to R _C matching			0.5	%

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ELECTRICAL CHARACTERISTICS (continued)

(V_{DD} = +15V ±5%, V_{SS} = -15V ±5%, V_{REF} = +10V, AGND = DGND = 0V, V_{OUT} connected to RFB, R_L = 2kΩ, C_L = 100pF, T_A = T_{MIN} to T_{MAX}, all grades, unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
DIGITAL INPUTS						
Input Current	I _{IN}	V _{IN} = 0V and V _{DD}		±1		μA
Input Low Voltage	V _{IL}			0.8		V
Input High Voltage	V _{IH}		2.4			V
Input Capacitance	C _{IN}			5		pF
POWER REQUIREMENTS						
Supply Voltage (Note 4)	V _{DD}		14.25		15.75	V
	V _{SS}		-14.25		-15.75	
Supply Current	I _{DD}	V _{OUT} unloaded		10		mA
	I _{SS}	V _{OUT} unloaded		4		
Power-Supply Rejection	PSR	V _{DD} only, V _{REF} = -10V		±0.2		%/%
		V _{SS} only		±0.2		

Note 2: Guaranteed monotonic over temperature.

Note 3: DAC register loaded with all 0s.

Note 4: The MX7845 can operate from ±12V supplies.

TIMING CHARACTERISTICS

(V_{DD} = +15V ±5%, V_{SS} = -15V ±5%, V_{REF} = +10V, AGND = DGND = 0V, T_A = T_{MIN} to T_{MAX}, all grades, unless otherwise noted.) (Note 5)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Chip Select to Write-Setup Time	t _{CS}	T _A = +25°C	100			ns
		MX7845J/K/A/B	135			
		MX7845S/T	140			
Chip Select to Write-Hold Time	t _{CH}	T _A = +25°C	0			ns
		MX7845J/K/A/B	0			
		MX7845S/T	0			
Write Pulse Width	t _{WR}	T _A = +25°C	100			ns
		MX7845J/K/A/B	135			
		MX7845S/T	140			
Data-Setup Time	t _{DS}	T _A = +25°C	100			ns
		MX7845J/K/A/B	100			
		MX7845S/T	120			
Data-Hold Time	t _{DH}	T _A = +25°C	20			ns
			20			

Note 5: All input signal rise and fall times measured from 10% to 90% of +5V; t_r = t_f = 20ns. Timing measurement reference is (V_{IH} + V_{IL})/2.

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AC PERFORMANCE CHARACTERISTICS

($T_A = T_{MIN}$ to T_{MAX} , all grades, unless otherwise noted.) (Note 6)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
DYNAMIC PERFORMANCE						
Output-Voltage Settling Time (Note 7)	t_S	V_{OUT} LOAD = $2k\Omega$, $100pF$		2.5	5.0	μs
Slew Rate	SR	V_{OUT} LOAD = $2k\Omega$, $100pF$		7		V/ μs
DAC Glitch Impulse (Note 8)				450		(nV)(s)
Multiplying Feedthrough Error (Note 9)				5		mV _{p-p}
Unity-Gain Small-Signal Bandwidth (Note 10)		V_{OUT} , RFB connected		600		kHz
Full-Power Bandwidth (Note 11)		V_{OUT} , RFB connected, $R_L = 2k\Omega$		250		kHz
Total Harmonic Distortion (Note 12)	THD			-90		dB
OUTPUT CHARACTERISTICS (Note 13)						
Open-Loop Gain	A_{VO}	$V_{OUT} = \pm 10V$, $R_L = 2k\Omega$	85			dB
Output Voltage Swing	V_O	$R_L = 2k\Omega$, $C_L = 100pF$	± 10			V
Output Resistance	R_O	RFB, V_{OUT} connected		0.2		Ω
Short-Circuit Current		V_{OUT} , AGND connected; $T_A = +25^\circ C$		15		mA
Output Noise Voltage (Note 14)		$T_A = +25^\circ C$	0.1Hz to 10Hz	2		μV_{RMS}
			f = 10Hz	250		$nV\sqrt{Hz}$
			f = 100Hz	100		
			f = 1kHz	50		
			f = 10kHz	50		
			f = 100kHz	50		

Note 6: AC PERFORMANCE CHARACTERISTICS are included for design guidance and are not subject to test.

Note 7: Settling to 0.01% of full-scale range. DAC register alternately loaded with all 0s and all 1s.

Note 8: Measured with $V_{REF} = 0V$. DAC register alternately loaded with all 1s and all 0s.

Note 9: $V_{REF} = \pm 10V$, 10kHz sine wave. DAC register loaded with all 0s.

Note 10: DAC register loaded with all 1s. $V_{REF} = 100mV_{p-p}$ sine wave.

Note 11: DAC register loaded with all 1s. $V_{REF} = 20V_{p-p}$ sine wave.

Note 12: $V_{REF} = 6V_{RMS}$, 1kHz sine wave.

Note 13: $2k\Omega$ minimum specified load resistance.

Note 14: Includes output amplifier noise and Johnson Noise of RFB.

Pin Description

DIP/SO PIN	PLCC/ LCC PIN	NAME	FUNCTION
1	2	V_{OUT}	Voltage Output
2-11	3-7, 9-13	D11-D2	Data Bits 2 to 11 (MSB)
12	14	DGND	Digital Ground
13, 14	16, 17	D1, D0	Data Bits 0 to 1 (LSB)
15	18	WR	Write Input. Active Low.
16	19	CS	Chip-Select Input. Active Low.
17	20	V_{REF}	Reference Input to DAC
18	21	AGND	Analog Ground

DIP/SO PIN	PLCC/ LCC PIN	NAME	FUNCTION
19	23	V_{SS}	-12V to -15V Supply Voltage Input
20	24	V_{DD}	+12V to +15V Supply Voltage Input
21	25	RA	Scaling Resistor: $RA = 4R_{FB}$
22	26	RB	Scaling Resistor: $RB = 2R_{FB}$
23	27	RC	Scaling Resistor: $RC = 2R_{FB}$
24	28	RFB	Feedback Resistor
	1, 8, 15, 22	N.C.	No Connect

For application information, refer to the MAX501/MAX502 data sheet.

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